

Artificial Intelligence for Quality Assurance and Troubleshooting in Industry

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Agenda

- Introduction
- X-Quality Conceptual Framework
- Combining AI and FTA
- Discussion
- Conclusion

Introduction

Problem Description

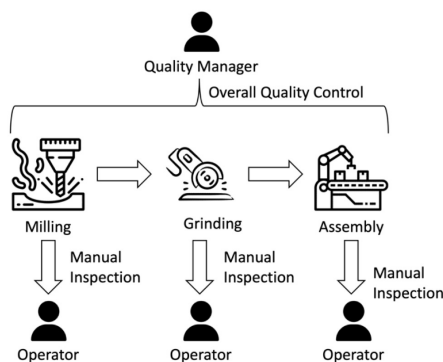
- Monitoring manufacturing processes is essential to prevent failures and maintain product quality.
- Using AI to automate quality assurance and improve accuracy and consistency in defect detection.
- Results produced by AI must be explainable to enable troubleshooting and acceptance by experts and regulators.

Objective

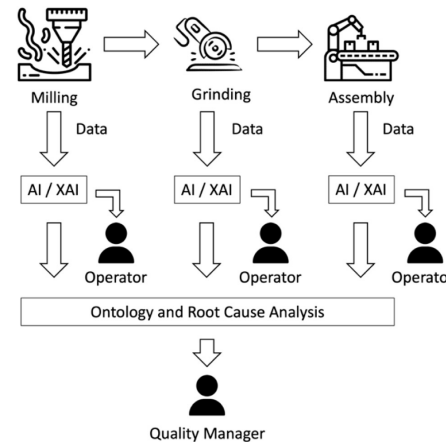
- Improve quality assurance and troubleshooting processes using AI/XAI

X-Quality Conceptual Framework

- In multi-stage manufacturing processes failures at one process can propagate, affecting subsequent processes
- Each operator does manual quality control at machine and quality manager supervises overall process



a) Manual Quality Control



b) Quality Control with AI, XAI and Stream Reasoning

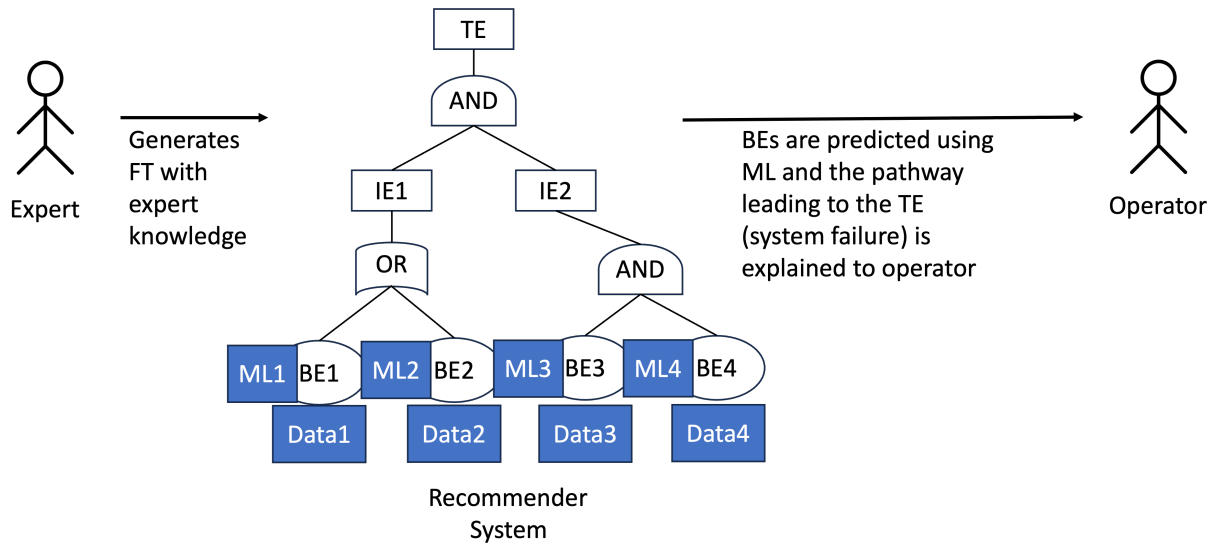
- From each machine data is collected and AI/XAI techniques are applied
- Data streams, predictions, and explanations are used to enrich ontology
- Quality manager used ontology to trace root cause

X-Quality Conceptual Framework

- 3 approaches integrated into the X-Quality conceptual framework
- 1) LSTM-CNN combination to predict quality issues in time series data and SHAP for explanation
- 2) Combination of AI and FTA for transparent TE occurrence
- 3) Stream reasoning to process continuous real-time data streams from multiple sources and enrich ontology. Using ontology to trace quality issues back to root causes

Combining AI and FTA

- Combining AI and FTA to enhance prediction and understanding of system failures.
- Expert generates FT
- ML models are built to predict the BEs
- FTA to determine TE occurrence



Combining AI and FTA

- Proof of Concept
- Using a simple FT focusing on Hardware failures
- Using **2 datasets** to predict the BEs:

- ❖ **SOFI** (**S**ymptom-**F**ault relationship for **IP**-Network):

Information about extensive enterprise network's performance

34 features (e.g. Bits received, speed, ...)

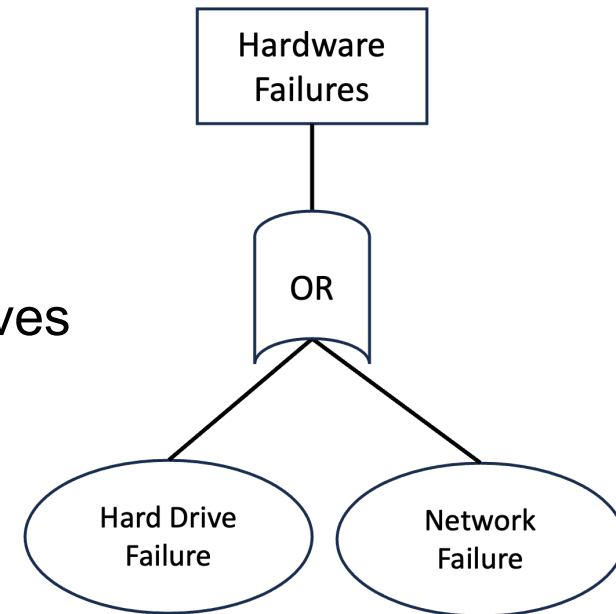
<https://data.mendeley.com/datasets/tc6ysmh5j8/2>

- ❖ **SMART**: S.M.A.R.T attributes from hard drives

56 features

<https://www.kaggle.com/datasets/sskanyal/>

[harddrive-cleaned-smart-dataset](#)



Combining AI and FTA

Predicting the TE

- Merging both datasets to predict the TE
- Using features of both datasets for TE prediction
- Using DL model

Predicting the BEs

- Using both datasets
- Using two DL models (one model each dataset)
- FTA to determine TE occurrence

Combining AI and FTA

Results

- K-fold cross validation with 10 splits

Metric	TE Prediction	BEs Prediction
Accuracy	99.1 %	99.4 %
Precision	99.7 %	99.8 %
Recall	98.6 %	99.1 %
F1-Score	99.2 %	99.5 %
AUC-ROC	99.9 %	99.6 %

- Approach „BEs prediction“ slightly better
- Additional benefit:
 - Identification of root causes
 - Interpretability of results
- However, BE prediction might be opaque

Strengths of the X-Quality Conceptual Framework

- Enhanced defect detection and troubleshooting by integrating AI, XAI, and expert knowledge
- Provides actionable explanations and contextual insights

Challenges of the X-Quality Conceptual Framework

- High computational resources for large-scale deployment
- Ontology and fault tree updates require expert input

Future Work

- Improving scalability by automating ontology updates
- Improving interpretability and comprehensibility of explanation
- Developing methods to process high-frequency data for real-world deployment

Conclusion

- The X-Quality Conceptual Framework combines AI, XAI, and expert knowledge
- Offering explanations to enable troubleshooting
- Downtime reduction, efficiency improvement, and cost reduction

DL architecture:

Layer	Units	Activation Function
Dense1	128	ReLu
Dense2	64	ReLu
Dense3	32	ReLu
Dense4	1	Sigmoid

Hyperparameters

- Optimizer: Adam (lr=0.001)
- Loss: Binary Crossentropy
- Epochs: 30
- Batch Size: 32